


<b>Search Notes</b>  	<b>Application/Control No.</b>  10796599	<b>Applicant(s)/Patent Under Reexamination</b>  FENG, WEISHI
	<b>Examiner</b>  San Juan, Martin Jeriko P	<b>Art Unit</b>  2109

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE for initial search strategy (Del Sole, Joseph)	2/26/2007	MJSJ
EAST Search (see attached).	2/26/2007	MJSJ
Consulted with Art Unit 2132 for reference quality check (Heneghan, Matthew)	3/01/2007	MJSJ
Inventor Search, reviewed related applications (see attached)	2/26/2007	MJSJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner